RENESAS FemtoClocksTM Crystal-to-LVCMOS/ LVTTL Frequency Synthesizer

DATASHEET

GENERAL DESCRIPTION

The 840002I is a 2 output LVCMOS/LVTTL Synthesizer optimized to generate Fibre Channel reference clock frequencies. Using a 26.5625MHz 18pF parallel resonant crystal, the following frequencies can be generated based on the 2 frequency select pins (F_SEL1:0): 212.5MHz, 159.375MHz, 156.25MHz, 106.25MHz, and 53.125MHz. The 840002I uses IDT's 3rd generation low phase noise VCO technology and can achieve 1ps or lower typical rms phase jitter, easily meeting Fibre Channel jitter requirements. The 840002I is packaged in a 16-pin TSSOP package.

FEATURES

- Two LVCMOS outputs @ 3.3V, 17Ω typical output impedance
- · Selectable crystal oscillator interface or LVCMOS single-ended input
- Output frequency range: 46.66MHz 233.33MHz
- VCO range: 560MHz 700MHz
- Supports the following output frequencies: 212.5MHz, 159.375MHz, 156.25MHz, 106.25MHz and 53.125MHz
- RMS phase jitter @ 212.5MHz (637KHz 10MHz): 0.83ps (typical)

Typical phase noise at 212.5MHz:

Offset	Noise Power
100Hz	91.3 dBc/Hz
1KHz	114.3 dBc/Hz
10KHz	120.7 dBc/Hz
100KHz	120.2 dBc/Hz

Power supply modes:

Core/Output 3.3V/3.3V

3.3V/2.5V

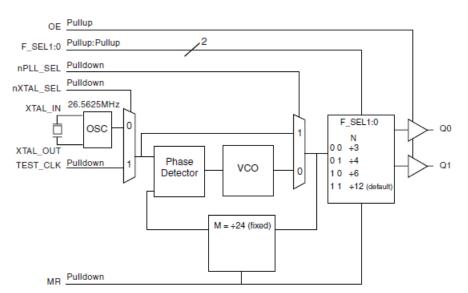
2.5V/2.5V

- -40°C to 85°C ambient operating temperature
- · Lead-Free package RoHS compliant

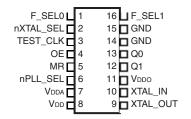
Input Frequency		Inputs					
(MHz)	F_SEL1	F_SEL0	M Divider Value	N Divider Value	M/N Ratio Value	(MHz)	
26.5625	0	0	24	3	8	212.5	
26.5625	0	1	24	4	6	159.375	
26.5625	1	0	24	6	4	106.25	
26.5625	1	1	24	12	2	53.125	
26.04166	0	1	24	4	6	156.25	

BLOCK DIAGRAM

FREQUENCY SELECT FUNCTION TABLE



PIN ASSIGNMENT



840002I

16-Lead TSSOP 4.4mm x 5.0mm x 0.92mm package body

G Package Top View



TABLE 1. PIN DESCRIPTIONS

Number	Name	Ту	/pe	Description
1, 16	F_SEL0, F_ SEL1	Input	Pullup	Frequency select pins. LVCMOS/LVTTL interface levels.
2	nXTAL_SEL	Input	Pulldown	Selects between the crystal or TEST_CLK inputs as the PLL reference source. When HIGH, selects TEST_CLK. When LOW, selects XTAL inputs. LVCMOS/LVTTL interface levels.
3	TEST_CLK	Input	Pulldown	Single-ended LVCMOS/LVTTL clock input.
4	OE	Input	Pullup	Output enable pin. When HIGH, the outputs are active. When LOW, the outputs are in a high impedance state. LVCMOS/LVTTL interface levels.
5	MR	Input	Pulldown	Active HIGH Master Reset. When logic HIGH, the internal dividers are reset causing active outputs to go low. When logic LOW, the internal dividers and the outputs are enabled. LVCMOS/LVTTL interface levels.
6	nPLL_SEL	Input	Pulldown	PLL Bypass. When LOW, the output is driven from the VCO output. When HIGH, the PLL is bypassed and the output frequency = reference clock frequency/n output divider. LVCMOS/LVTTL interface levels.
7	V _{DDA}	Power		Analog supply pin.
8	V _{DD}	Power		Core supply pin.
9, 10	XTAL_OUT, XTAL_IN	Input		Crystal oscillator interface. XTAL_IN is the input. XTAL_OUT is the output.
11	V _{DDO}	Power		Output supply pin.
12, 13	Q1, Q0	Output		Single-ended clock outputs. LVCMOS/LVTTL interface levels.
14, 15	GND	Power		Power supply ground.

NOTE: Pullup and Pulldown refer to internal input resistors. See Table 2, Pin Characteristics, for typical values.

Table 2. Pin Characteristics

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
C _{IN}	Input Capacitance			4		pF
C _{PD}	Power Dissipation Capacitance			8		pF
R _{PULLUP}	Input Pullup Resistor			51		kΩ
R _{PULLDOWN}	Input Pulldown Resistor			51		kΩ
В	Output Impadance	3.3V±5%	14	17	21	Ω
R _{OUT}	Output Impedance	2.5V±5%	16	21	25	Ω

TABLE 3. FREQUENCY SELECT FUNCTION TABLE

Input Frequency		Output Frequency				
(MHz)	F_SEL1	F_SEL0	M Divider Value	N Divider Value	M/N Divider Value	(MHz)
26.5625	0	0	24	3	8	212.5
26.5625	0	1	24	4	6	159.375
26.5625	1	0	24	6	4	106.25
26.5625	1	1	24	12	2	53.125
26.04166	0	1	24	4	6	156.25



ABSOLUTE MAXIMUM RATINGS

Supply Voltage, V_{DD} 4.6V

Inputs, V_{I} -0.5V to V_{DD} + 0.5 V

Outputs, V_{O} -0.5V to V_{DD} + 0.5V

Package Thermal Impedance, θ_{JA} 89°C/W (0 lfpm)

Storage Temperature, T_{STG} -65°C to 150°C

NOTE: Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These ratings are stress specifications only. Functional operation of product at these conditions or any conditions beyond those listed in the *DC Characteristics* or *AC Characteristics* is not implied. Exposure to absolute maximum rating conditions for extended periods may affect product reliability.

 $\textbf{TABLE 4A. Power Supply DC Characteristics, V}_{\text{DD}} = V_{\text{DDA}} = 3.3V \pm 5\%, V_{\text{DDO}} = 3.3V \pm 5\% \text{ or } 2.5V \pm 5\%, TA = -40^{\circ}\text{C to } 85^{\circ}\text{C}$

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
V _{DD}	Core Supply Voltage		3.135	3.3	3.465	V
V _{DDA}	Analog Supply Voltage		3.135	3.3	3.465	V
	Outrout Complex Valtage		3.135	3.3	3.465	V
V _{DDO}	Output Supply Voltage		2.375	2.5	2.625	V
I _{DD}	Power Supply Current				100	mA
I _{DDA}	Analog Supply Current				12	mA
I _{DDO}	Output Supply Current				5	mA

Table 4B. Power Supply DC Characteristics, $V_{DD} = V_{DDA} = V_{DDO} = 2.5V \pm 5\%$, Ta = -40°C to 85°C to 85

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
V _{DD}	Core Supply Voltage		2.375	2.5	2.625	V
V_{DDA}	Analog Supply Voltage		2.375	2.5	2.625	V
V _{DDO}	Output Supply Voltage		2.375	2.5	2.625	V
I _{DD}	Power Supply Current				95	mA
I _{DDA}	Analog Supply Current				12	mA
I _{DDO}	Output Supply Current				5	mA



Table 4C. LVCMOS/LVTTL DC Characteristics, $V_{DD} = V_{DDA} = V_{DDO} = 3.3V \pm 5\%$ or $2.5V \pm 5\%$, or $V_{DD} = V_{DDA} = 3.3V \pm 5\%$, $V_{DDO} = 2.5V \pm 5\%$, Ta = -40°C to 85° C

Symbol	Parameter		Test Conditions	Minimum	Typical	Maximum	Units
V	Input High Voltage		$V_{DD} = 3.465V$	2		V _{DD} + 0.3	V
V _{IH}	input riigir voit	aye	$V_{DD} = 2.625V$	1.7		V _{DD} + 0.3	V
V	Input Low Volta	200	$V_{DD} = 3.465V$	-0.3		0.8	V
V_{IL}	Imput Low Voite	19 0	$V_{DD} = 2.625V$	-0.3		0.7	V
	Input	OE	$V_{DD} = V_{IN} = 3.465V$ or 2.625V			5	μΑ
I IH	High Current	F_SEL0:1, nPLL_SEL, MR, nXTAL_SEL, TEST_CLK	$V_{DD} = V_{IN} = 3.465V$ or 2.625V			150	μΑ
	Input	OE	$V_{DD} = 3.465V \text{ or } 2.625V,$ $V_{IN} = 0V$	-150			μΑ
i I _{IL}	Low Current	F_SEL0:1, nPLL_SEL, MR, nXTAL_SEL, TEST_CLK	$V_{DD} = 3.465V \text{ or } 2.625V,$ $V_{IN} = 0V$	-5			μΑ
V	Output	High Voltage; NOTE 1	$V_{DDO} = 3.3V \pm 5\%$	2.6			V
V _{OH}	Output	I light voltage, NOTE 1	$V_{DDO} = 2.5V \pm 5\%$	1.8			V
V _{OL}	Output	Low Voltage; NOTE 1	$V_{DDO} = 3.3 \text{V or } 2.5 \text{V} \pm 5\%$			0.5	V

NOTE 1: Outputs terminated with 50Ω to $V_{DDO}/2$. See Parameter Measurement Information, Output Load Test Circuit.

TABLE 5. CRYSTAL CHARACTERISTICS

Parameter	Test Conditions	Minimum	Typical	Maximum	Units
Mode of Oscillation		Fu	ındamenta	I	
Frequency			26.5625		MHz
Equivalent Series Resistance (ESR)				50	Ω
Shunt Capacitance				7	pF

NOTE: Characterized using an 18pF parallel resonant crystal.

Table 6A. AC Characteristics, $V_{DD} = V_{DDA} = V_{DDO} = 3.3V \pm 5\%$, Ta = -40°C to 85°C

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
		F_SEL[1:0] = 00	186.67		226.67	MHz
f	Output Frequency Range	F_SEL[1:0] = 01	140		170	MHz
OUT	Output Frequency hange	F_SEL[1:0] = 10	93.33		113.33	MHz
		F_SEL[1:0] = 11	46.67		56.67	MHz
tsk(o)	Output Skew; NOTE 1, 3				12	ps
		212.5MHz @ Integration Range: 637KHz - 10MHz		0.83		ps
		159.375MHz @ Integration Range: 637KHz - 10MHz		0.62		ps
tjit(Ø)	RMS Phase Jitter (Random); NOTE 2	156.25MHz @ Integration Range: 1.875MHz - 20MHz		0.59		ps
		106.25MHz @ Integration Range: 637KHz - 10MHz		0.80		ps
		53.125MHz @ Integration Range: 637KHz - 10MHz		0.68		ps
t_R / t_F	Output Rise/Fall Time	20% to 80%	200		700	ps
odo	Output Duty Cyclo	F_SEL[1:0] 00	46		54	%
odc	Output Duty Cycle	F_SEL[1:0] = 00	42		58	%

NOTE 1: Defined as skew between outputs at the same supply voltages and with equal load conditions.

Measured at $\rm V_{\rm DDO}/2.$ NOTE 2: Please refer to the Phase Noise Plot.

NOTE 3: This parameter is defined in accordance with JEDEC Standard 65.

Table 6B. AC Characteristics, $V_{DD} = V_{DDA} = 3.3V \pm 5\%$, $V_{DDO} = 2.5V \pm 5\%$, Ta = -40°C to 85°C

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
		F_SEL[1:0] = 00	186.67		226.67	MHz
f	Output Fraguency Banga	F_SEL[1:0] = 01	140		170	MHz
t _{out}	Output Frequency Range	F_SEL[1:0] = 10	93.33		113.33	MHz
		F_SEL[1:0] = 11	46.67		56.67	MHz
tsk(o)	Output Skew; NOTE 1, 3				12	ps
		212.5MHz @ Integration Range: 637KHz - 10MHz		0.73		ps
		159.375MHz @ Integration Range: 637KHz - 10MHz		0.62		ps
tjit(Ø)	RMS Phase Jitter (Random); NOTE 2	156.25MHz @ Integration Range: 1.875MHz - 20MHz		0.56		ps
		106.25MHz @ Integration Range: 637KHz - 10MHz		0.76		ps
		53.125MHz @ Integration Range: 637KHz - 10MHz		0.72		ps
t _R / t _F	Output Rise/Fall Time	20% to 80%	200		700	ps
	Outrout Duty Ovela	F_SEL[1:0] 00	46		54	%
odc	Output Duty Cycle	F_SEL[1:0] = 00	42		58	%

NOTE 1: Defined as skew between outputs at the same supply voltages and with equal load conditions.

Measured at V_{DDO}/2.

NOTE 2: Please refer to the Phase Noise Plot.

NOTE 3: This parameter is defined in accordance with JEDEC Standard 65.



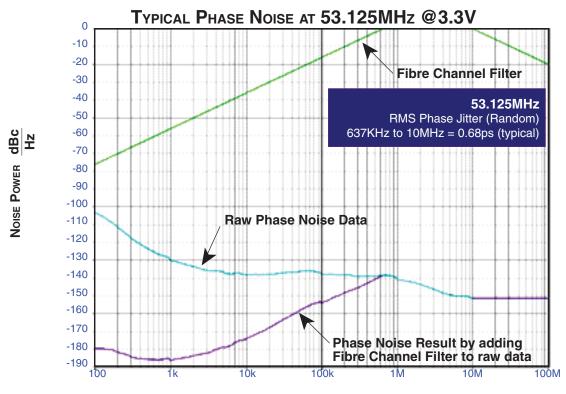
Table 6C. AC Characteristics, $V_{DD} = V_{DDA} = V_{DDO} = 2.5V \pm 5\%$, Ta = -40°C to 85°C

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
		F_SEL[1:0] = 00	186.67		226.67	MHz
f	Output Frequency Range	F_SEL[1:0] = 01	140		170	MHz
T _{OUT}	Output Frequency hange	F_SEL[1:0] = 10	93.33		113.33	MHz
		F_SEL[1:0] = 11	46.67		56.67	MHz
tsk(o)	Output Skew; NOTE 1, 3				12	ps
		212.5MHz @ Integration Range: 637KHz - 10MHz		0.78		ps
		159.375MHz @ Integration Range: 637KHz - 10MHz		0.67		ps
tjit(Ø)	RMS Phase Jitter (Random); NOTE 2	156.25MHz @ Integration Range: 1.875MHz - 20MHz		0.69		ps
		106.25MHz @ Integration Range: 637KHz - 10MHz		0.82		ps
		53.125MHz @ Integration Range: 637KHz - 10MHz		0.75		ps
t _R / t _F	Output Rise/Fall Time	20% to 80%	200		700	ps
odc	Output Duty Cycle	F_SEL[1:0] ¹ 00	46		54	%
louc	Output Duty Cycle	F_SEL[1:0] = 00	42		58	%

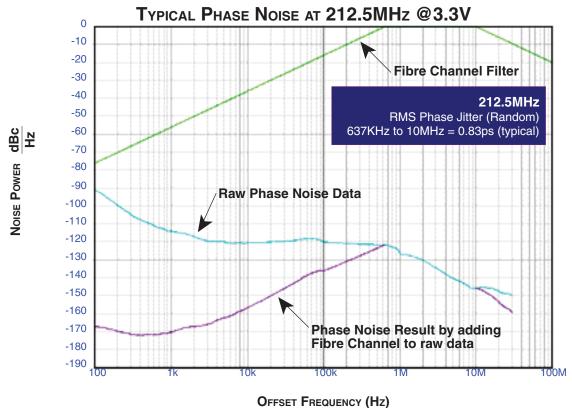
NOTE 1: Defined as skew between outputs at the same supply voltages and with equal load conditions.

Measured at $V_{\rm DDO}/2$. NOTE 2: Please refer to the Phase Noise Plot.

NOTE 3: This parameter is defined in accordance with JEDEC Standard 65.

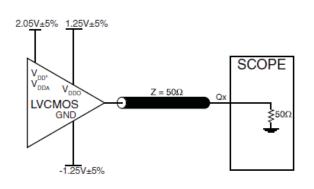


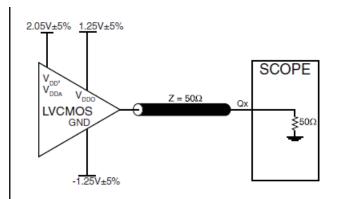






PARAMETER MEASUREMENT INFORMATION

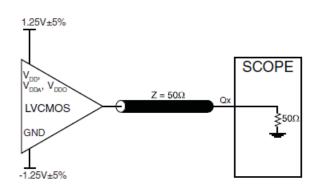


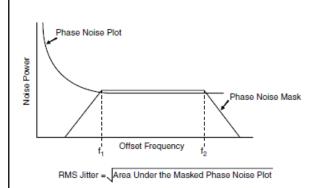


3.3V CORE/3.3V OUTPUT LOAD AC TEST CIRCUIT



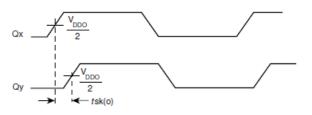
3.3V CORE/2.5V OUTPUT LOAD AC TEST CIRCUIT

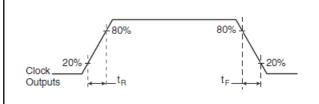




2.5V Core/2.5V OUTPUT LOAD AC TEST CIRCUIT

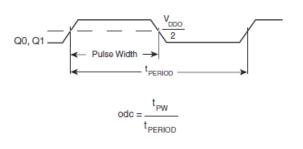
RMS PHASE JITTER





OUTPUT SKEW

OUTPUT RISE/FALL TIME



OUTPUT DUTY CYCLE/PULSE WIDTH/PERIOD



APPLICATION INFORMATION

Power Supply Filtering Techniques

As in any high speed analog circuitry, the power supply pins are vulnerable to random noise. The 840002l provides separate power supplies to isolate any high switching noise from the outputs to the internal PLL. $V_{\rm DD},\,V_{\rm DDA},\,$ and $V_{\rm DDO}$ should be individually connected to the power supply plane through vias, and bypass capacitors should be used for each pin. To achieve optimum jitter performance, power supply isolation is required. Figure 1 illustrates how a 10Ω resistor along with a $10\mu F$ and a $.01\mu F$ bypass capacitor should be connected to each $V_{\rm DDA}.$

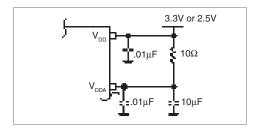


FIGURE 1. POWER SUPPLY FILTERING

CRYSTAL INPUT INTERFACE

The 840002l has been characterized with 18pF parallel resonant crystals. The capacitor values shown in *Figure 2* below were

determined using a 26.5625MHz 18pF parallel resonant crystal and were chosen to minimize the ppm error.

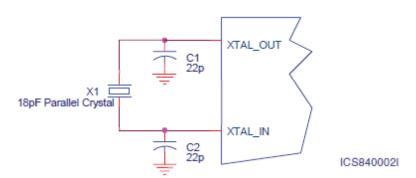


Figure 2. CRYSTAL INPUT INTERFACE



LAYOUT GUIDELINE

Figure 3 shows a schematic example of the 840002I. An example of LVCMOS termination is shown in this schematic. Additional LVCMOS termination approaches are shown in the LVCMOS Termination Application Note. In this example, an 18 pF parallel resonant 26.5625MHz crystal is used. The C1=22pF

and C2=22pF are recommended for frequency accuracy. For different board layout, the C1 and C2 may be slightly adjusted for optimizing frequency accuracy. $1K\Omega$ pullup or pulldown resistors can be used for the logic control input pins.

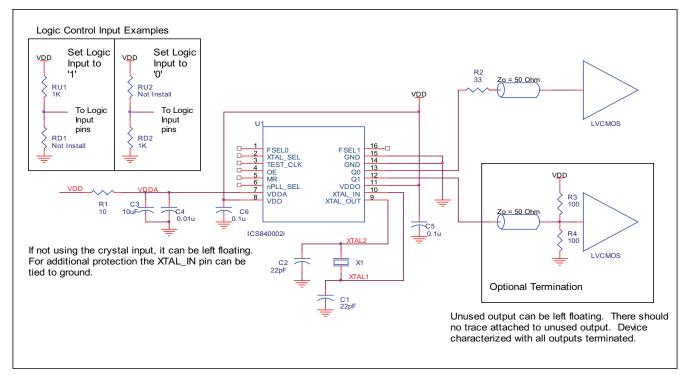


FIGURE 3. 8400021 SCHEMATIC EXAMPLE



RELIABILITY INFORMATION

Table 7. $\theta_{\text{JA}} \text{vs. Air Flow Table for 16 Lead TSSOP}$

θJA by Velocity (Linear Feet per Minute)

 0
 200
 500

 Single-Layer PCB, JEDEC Standard Test Boards
 137.1°C/W
 118.2°C/W
 106.8°C/W

 Multi-Layer PCB, JEDEC Standard Test Boards
 89.0°C/W
 81.8°C/W
 78.1°C/W

NOTE: Most modern PCB designs use multi-layered boards. The data in the second row pertains to most designs.

TRANSISTOR COUNT

The transistor count for 840002l is: 3085



PACKAGE OUTLINE - G SUFFIX FOR 16 LEAD TSSOP

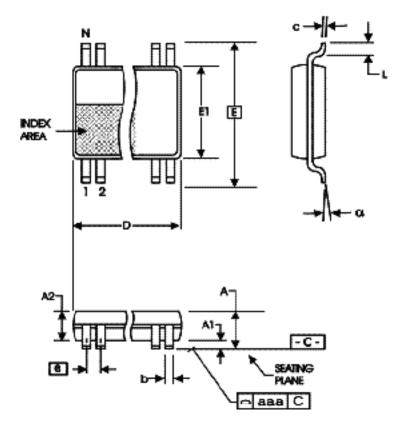


TABLE 8. PACKAGE DIMENSIONS

SYMBOL	Millimeters		
STWIDOL	Minimum	Maximum	
N	16		
А		1.20	
A1	0.05	0.15	
A2	0.80	1.05	
b	0.19	0.30	
С	0.09	0.20	
D	4.90	5.10	
E	6.40 BASIC		
E1	4.30	4.50	
е	0.65 BASIC		
L	0.45	0.75	
α	0°	8°	
aaa		0.10	

Reference Document: JEDEC Publication 95, MO-153



Table 9. Ordering Information

Part/Order Number	Marking	Package	Shipping Packaging	Temperature
840002AGILF	40002AIL	16 Lead "Lead-Free" TSSOP	tube	-40°C to 85°C
840002AGILFT	40002AIL	16 Lead "Lead-Free" TSSOP	2500 tape & reel	-40°C to 85°C

Parts that are ordered with an "LF" suffix to the part number are the Pb-Free configuration and are RoHS compliant.



REVISION HISTORY SHEET					
Rev	Table	Page	Description of Change	Date	
А	Т9	13	Ordering Information Table - deleted quantity from tube count. Added tape & reel to count.	1/22/07	
А	Т9	13 15	Updated datasheet's header/footer with IDT from ICS. Removed ICS prefix from Part/Order Number column. Deleted "ICS" from non-lead marking. Added Lead-free marking. Added Contact Page.	11/10/10	
А	Т9	13	Ordering Information - removed leaded devices. Updated data sheet format.	3/30/15	



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